

**Search Notes**

Application/Control No.

10/676,174

Examiner

Ellen C. Tran

Applicant(s)/Patent under  
Reexamination

KRTOLICA ET AL.

Art Unit

2134

**SEARCHED**

Class	Subclass	Date	Examiner
713	160	8/3/2007	ET
713	100	8/3/2007	ET
726	11	8/3/2007	ET

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
USPTO, USPG, EPO, JPO, DERWENT, IBM TECH DES	8/3/2007	ET
NPL - IEEE XPLORE	8/3/2007	ET
All claims were reviewed for possible 101 rejections	8/3/2007	ET